Search Notes



Application/Control No.	Applicant(s)/Patent und Reexamination	er
09/617,036	PAIK ET AL.	
Examiner	Art Unit	
Michael W. Hoye	2623	

SEARCHED				
Class Subclass		Date	Examiner	
725	1,39,62	8/18/2003	MRD	
455	556.1	8/19/2003	MRD	
455	556.2	8/19/2003	MRD	
455	557	8/19/2003	MRD	
Updated	Search	2/12/2004	MRD	
Updated	Search	11/3/2004	MRD	
455	452.1	11/3/2004	MRD	
455	453	11/3/2004	MRD	
455	63.1	11/3/2004	MRD	
Updated	Search	8/18/2005	MWH	
725	73,81,99	8/18/2005	MWH	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	-		
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Talked w/ Hunter Lonsberry - 725 Vivek Srivastava -Class 725	8/18/2003	MRD
Andy Faile - Class 725/455	8/19/2003	MRD
EAST Search	8/19/2003	MRD
Talked w/ Andrew Koenig - Class 725	11/2/2004	MRD
Talked w/ Chris Kelley Talked w/ William Trost - Class 455	11/3/2004	MRD
EAST Search	11/3/2004	MRD
Talked w/ Scott Beliveau and John Miller - Class 725	8/16/2005	мwн
EAST Search	8/18/2005	мwн

Search Notes (continued)



Application/Control No.	Applicant(s)/Patent under Reexamination	
09/617,036	PAIK ET AL.	
Examiner	Art Unit	
Michael W. Hove	2623	

SEARCHED				
Class	Subclass	Date	Examiner	
Updated	Search	8/16/2006	WWH	
Updated	Search	7/7/2007	мwн	
455	3.01	7/7/2007	мwн	
455	3.04-3.06	7/7/2007	мwн	
455	426.1-426	7/7/2007	MWH	
370	487	7/7/2007	MWH	
375	240.01	7/7/2007	мwн	
caeld	abce	1/15/08	M	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
725	3962	1/5/08	M

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Talked w/ Scott Beliveau - Class 725, and Brian Yenke	8/11/2006	мwн
EAST Search	8/16/2006	MWH
Talked w/ Hunter Lonsberry - Class 725 and Brian Yenke - Class 348	2/1/2007	мwн
Talked w/ Scott Beliveau and Hunter Lonsberry - Class 725 Talked w/ Philip Sobutka and William Trost (SPE) - Class 455	6/18/2007	мwн
Talked w/ Kevin Burd - Class 375	6/19/2007	мwн
STIC Search Report - EIC 2600 Talked w/ Brain Yenke and David Harvey (Class 348) Talked w/ Andrew Koenig	6/28/2007	мwн
EAST Search	7/7/2007	MWH
Involo none sevia	1115/08	1412